

mec

INTRODUCING THE EUV CNT PELLICLE

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BACKGROUND

SOLUTIONS EXIST FOR LOW POWER

- Initial solutions exist for pilot/product phases, but are not viable for high powers

	Product Phase	Target specifications		
		Transmission	Transmission non-uniformity	Power capability
Pellicle film generations	Pilot	>80%	1%	>125W
	Product	88%	0.4%	250W
	Future	≥90%	0.4%	>250W

metal
SiN
pSi
SiN

cap1
pSi
cap2

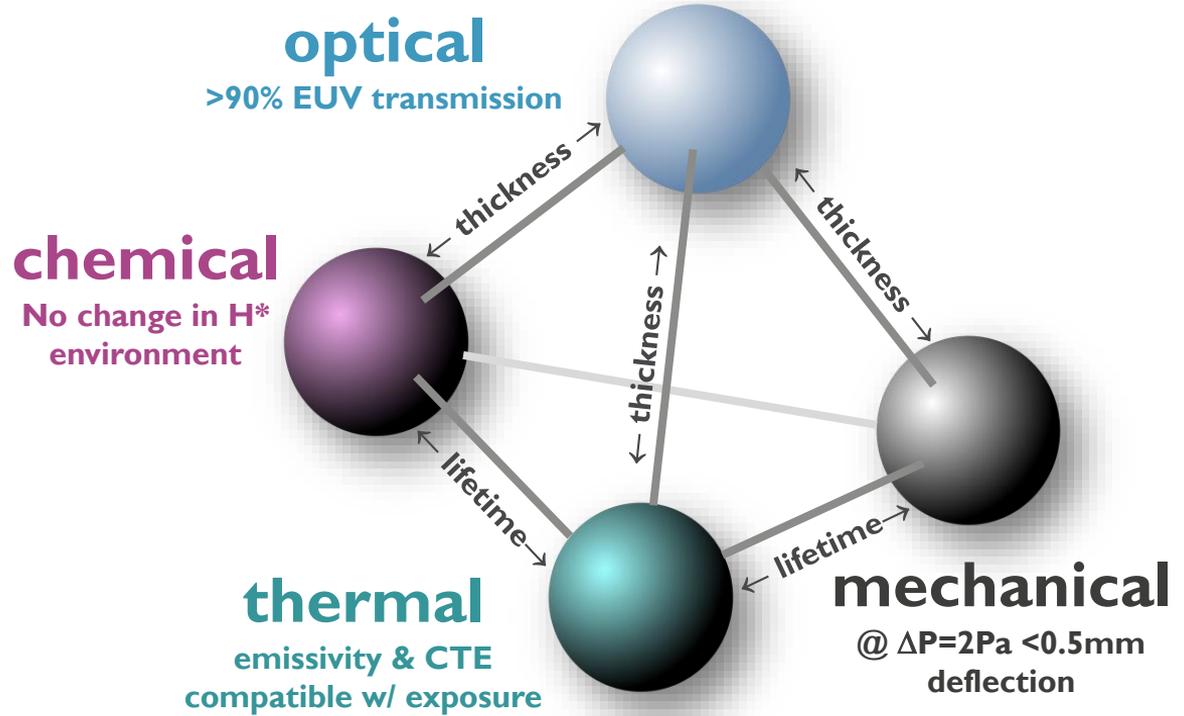
D. Brouns, et al. " NXE pellicle: development update", Proc. SPIE 9985, Photomask Technology 2016

Imec is developing a pellicle to meet ~>250W source power requirements

PELLICLE REQUIREMENTS

PYRAMID VIEW

- Layers added to improve chemical resistance or thermal properties reduce transmission
- Thicker layers are generally have improved mechanical strength
- Pellicle requirements are connected and must be balanced



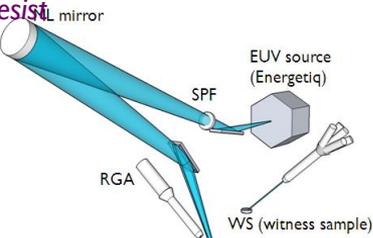
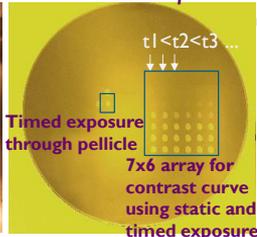
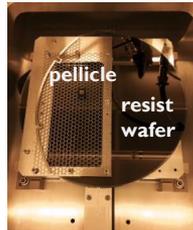
Pellicle membrane screening demands multiple metrology methods

PELLICLE TESTING SUITE @ IMEC

PLUS: RAMAN, XRD, MODELING, ..

optical

Printed result in photoresist



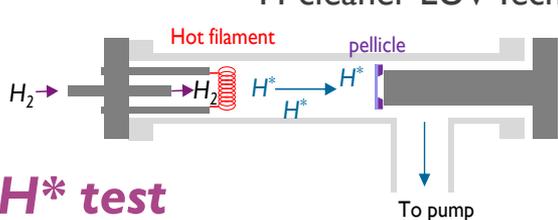
Transmission test

EUV Tech outgas tester

I. Pollentier, et al., EUVL Symposium (Maastricht, October 2015)

chemical

H-cleaner EUV Tech



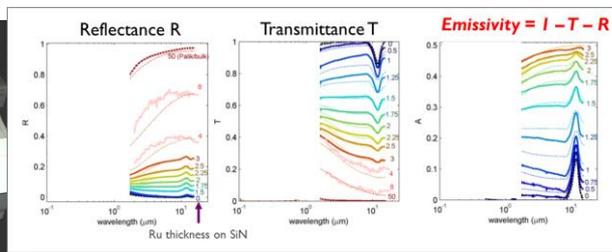
H* test

I. Pollentier, et al., EUVL Symposium (Maastricht, October 2015)

thermal



FTIR



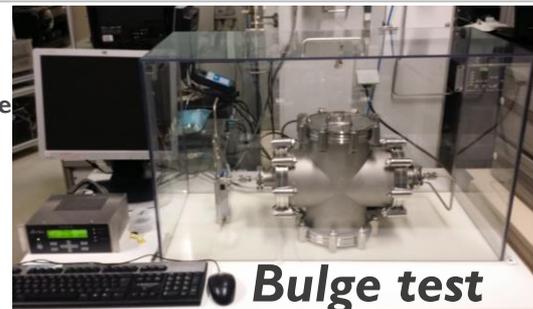
Emissivity measurement

[P.J. Van Zwol (ASML), JAP 2015]

mechanical



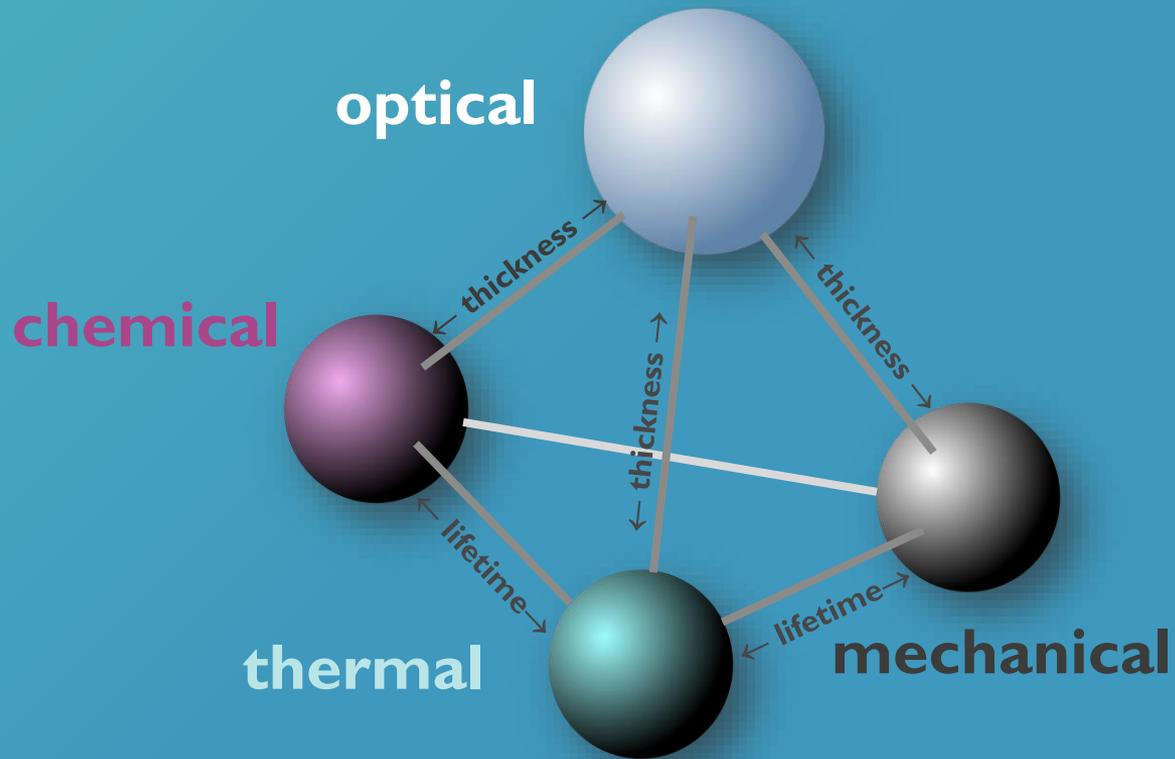
Measurement of 'pressure to burst'



Bulge test

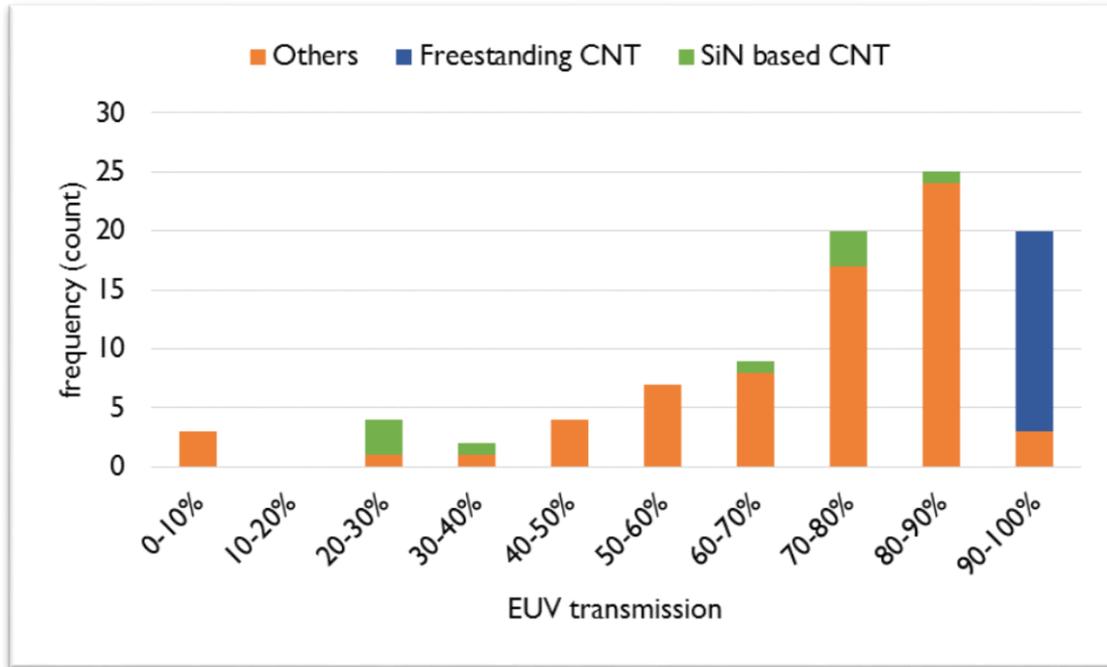
J.U. Lee, et al., SPIE Photomask, (San Jose, September 2016)

CNT-BASED PELLICLE AND TRANSMISSION



WHY INVESTIGATE CNT-BASED PELLICLE MEMBRANES?

SAMPLES TESTED AT IMEC FOR PELLICLE APPLICATION

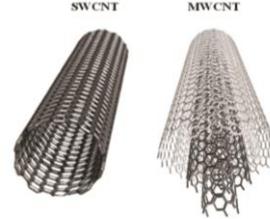


CNT without capping layer has very high transmission at EUV wavelengths

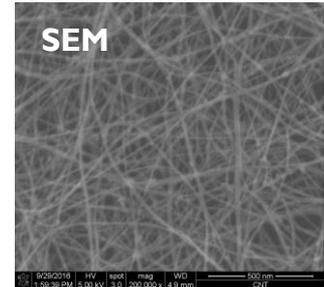
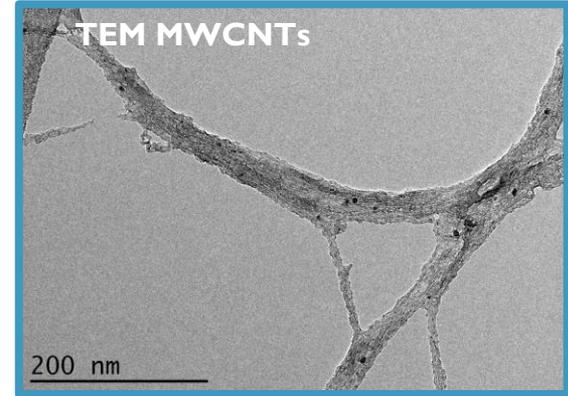
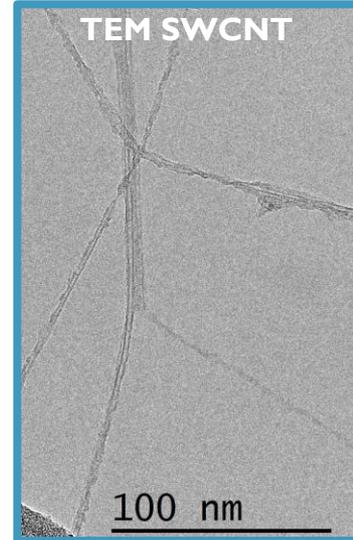
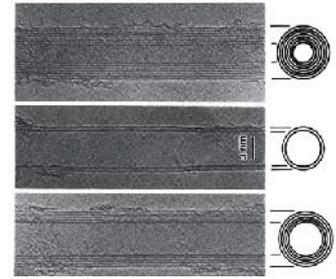
CNTS

BASIC FACTS

- CNT = sheet of carbon rolled into a cylinder
 - Single-walled (SWCNT): diameter ~1 nm
 - Multi-walled (MWCNT): diameter ~5-30 nm
 - CNT bundles can be long (>100 μm)
- General properties: strong, thermally stable, flexible platform for optimizing
- CNTs can form strong, ~2D network



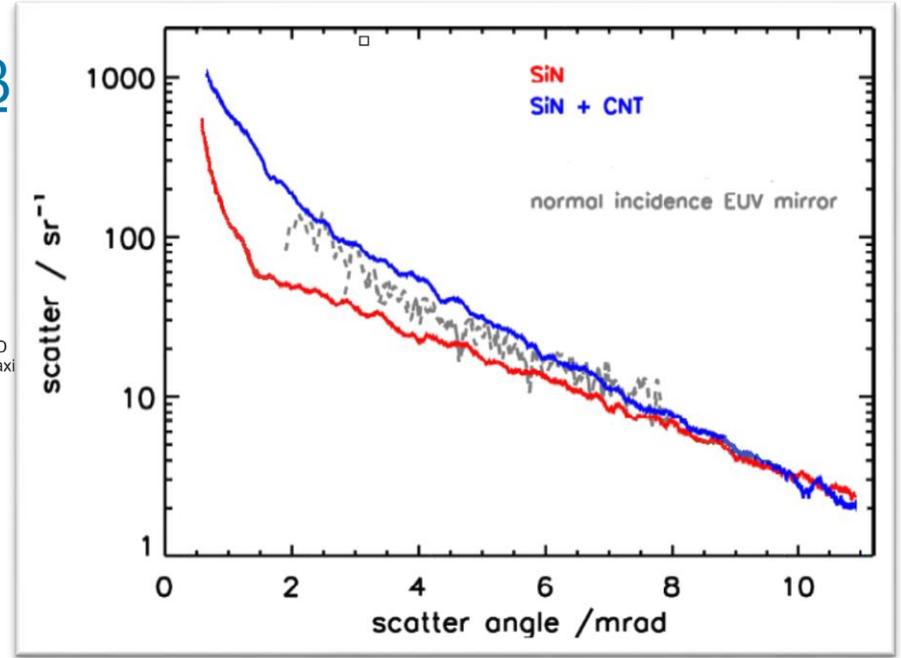
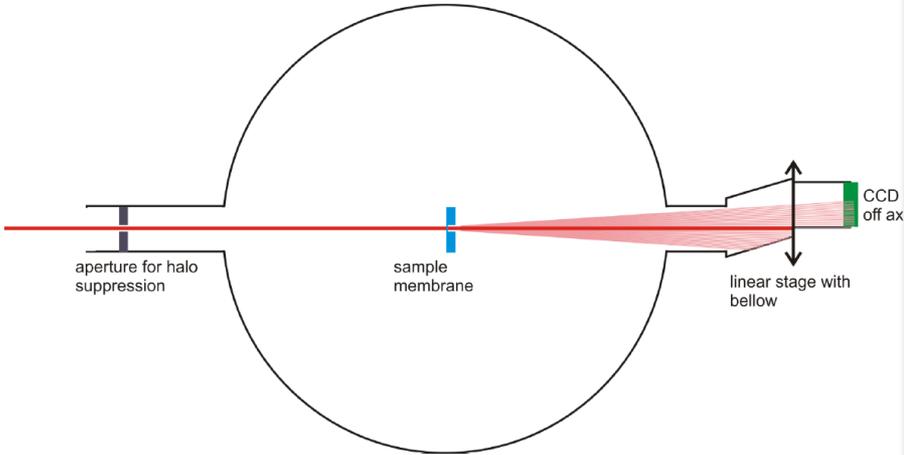
Sumio Iijima,
Nature 354,
6348, 1991



EUV SCATTERING FROM CNT FILMS

PTB SCATTERING MEASUREMENTS

EUV scatter: scheme of measurement



Small increase in scatter for SiN+CNT, but values are comparable to Si/Mo multilayer mirror surface.

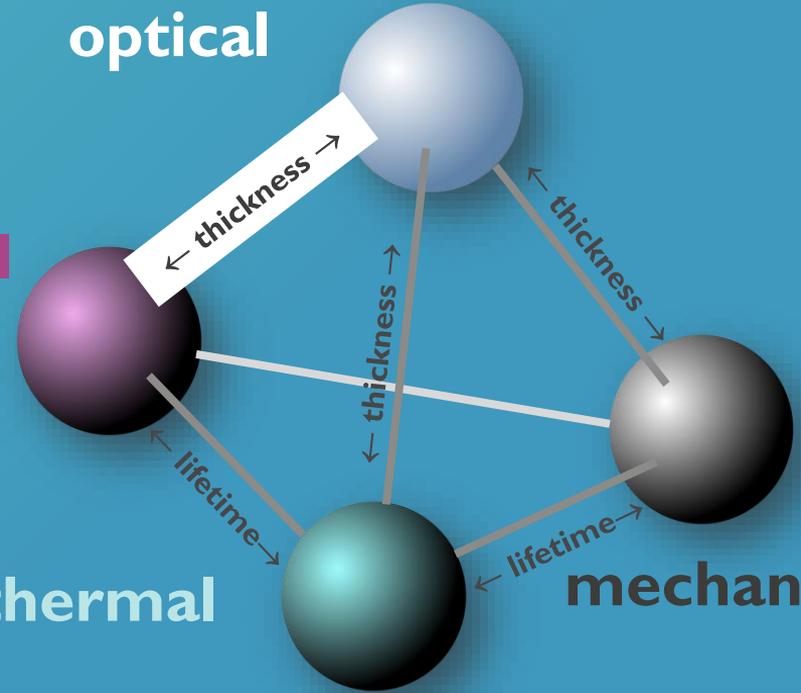
CHEMICAL TEST & COATING MEMBRANES

chemical

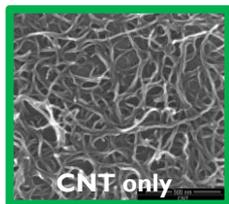
optical

thermal

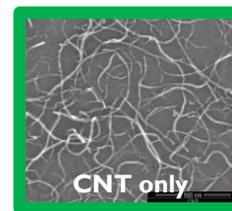
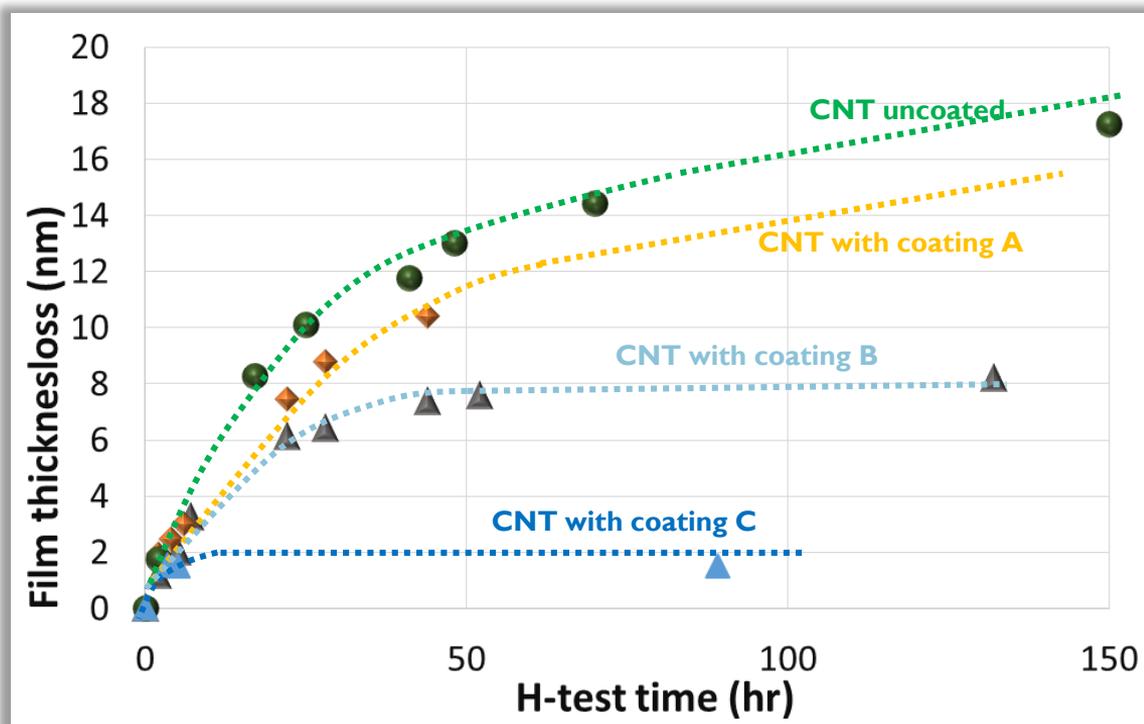
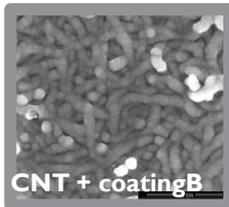
mechanical



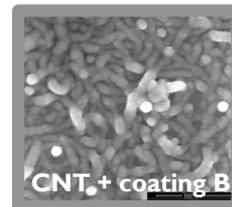
H* TEST: CAPPING LAYER IDENTIFICATION



Before H*-test



After H*-test

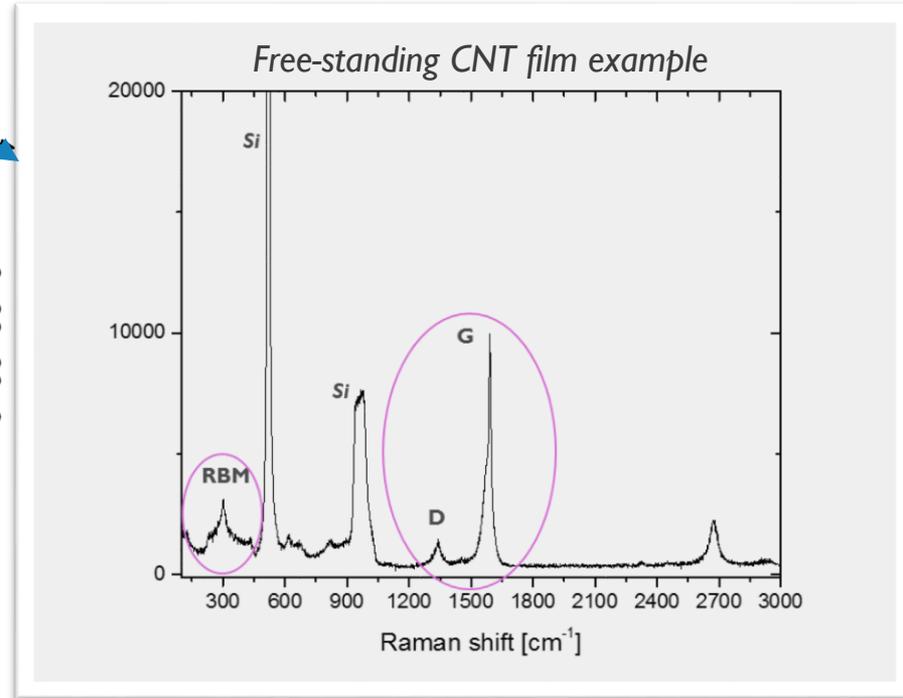
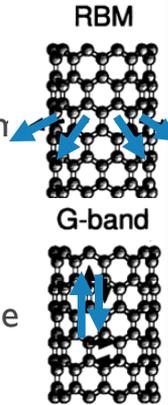


Coated CNT demonstrate flatter response after initial H* exposure.

CHANGE IN FILMS AFTER H* EXPOSURE

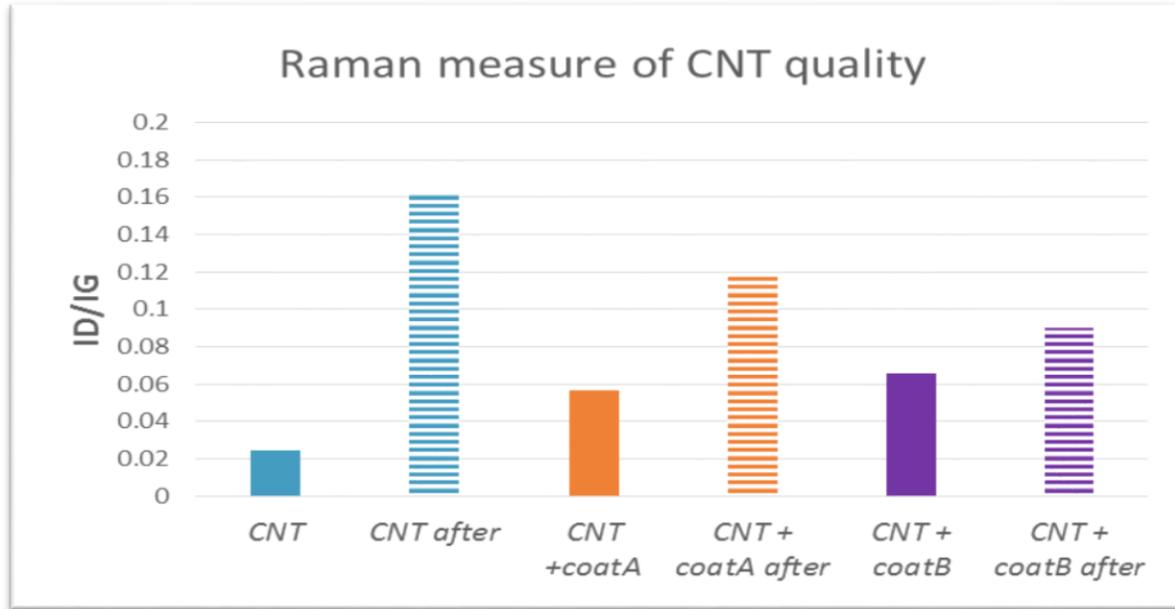
RAMAN SPECTROSCOPY

- Reading CNT Raman spectra
 - RBM** (radial breathing mode): carbon atoms move in-phase in the radial direction = SWCNTs
 - G-band**: neighboring atoms are moving in opposite directions along the surface of the tubes
 - D-band** (disorder-induced band): scattering from a defect which breaks the basic symmetry
- Intensity ratio D/G shows structural quality
 - Can be used to study changes



RAMAN CHANGES AFTER H* EXPOSURE FOR 130 HRS

LOW VALUES ARE BEST



While coating improves CNT resistance to H*, optimization is needed

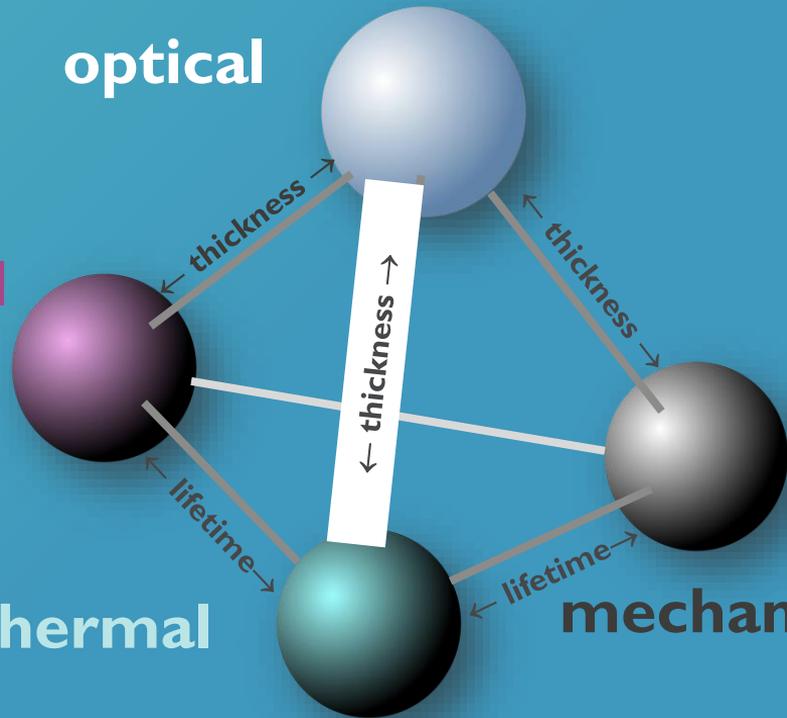
THERMAL TESTING

chemical

optical

thermal

mechanical



HEAT & EMISSIVITY

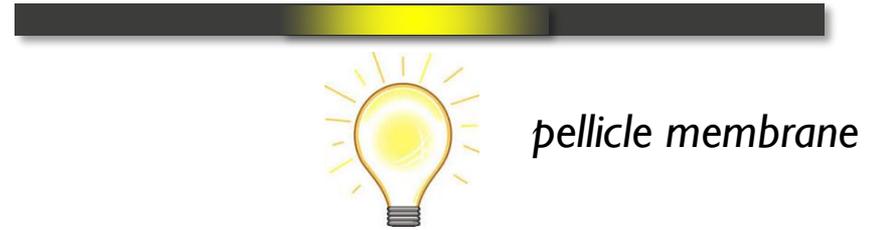
FOURIER TRANSFORM INFRARED SPECTROSCOPY (FTIR)

- For thin membranes in vacuum, primary heat loss is through radiation (emission)
- At thermal equilibrium, absorption and emissivity ε are balanced (Kirchhoff's Law)

$$\varepsilon = A = I - R - T$$

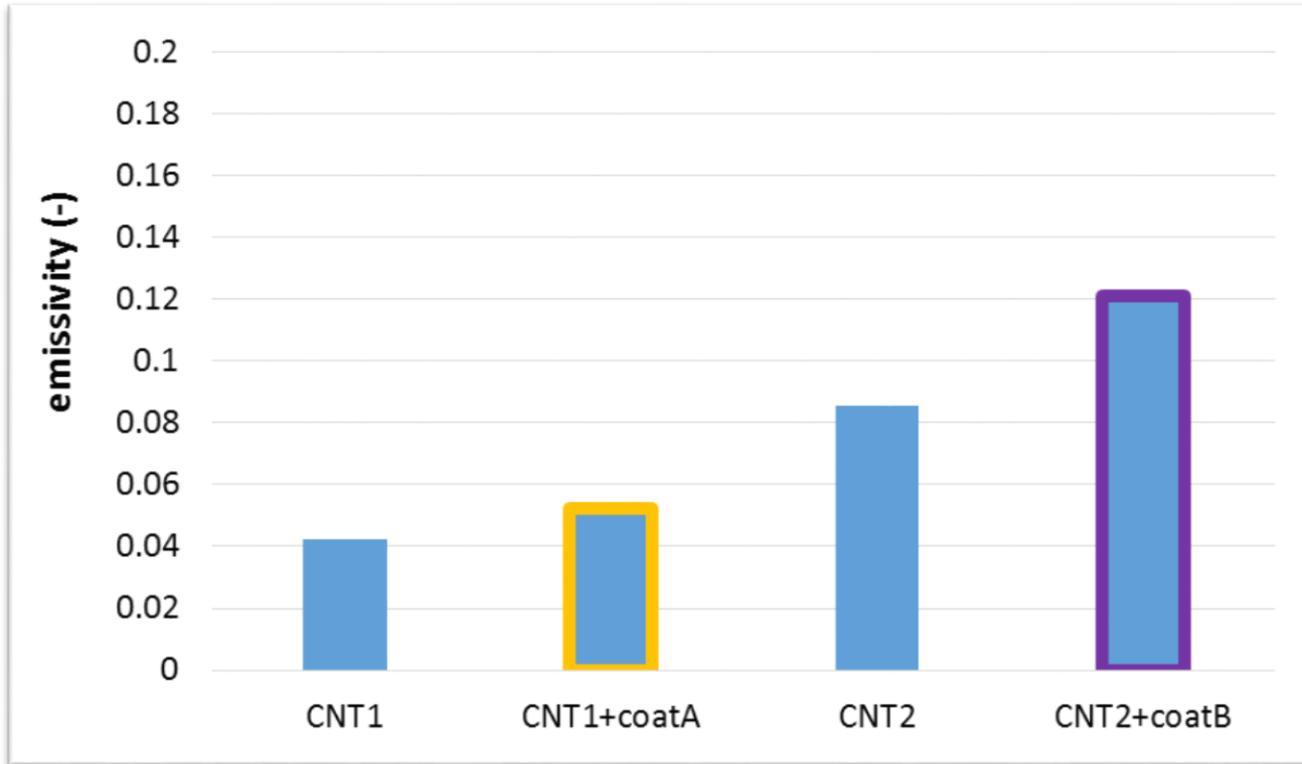
values for ε 0=vacuum; I =perfect black body

- Commercial FTIR system enables emissivity measurements



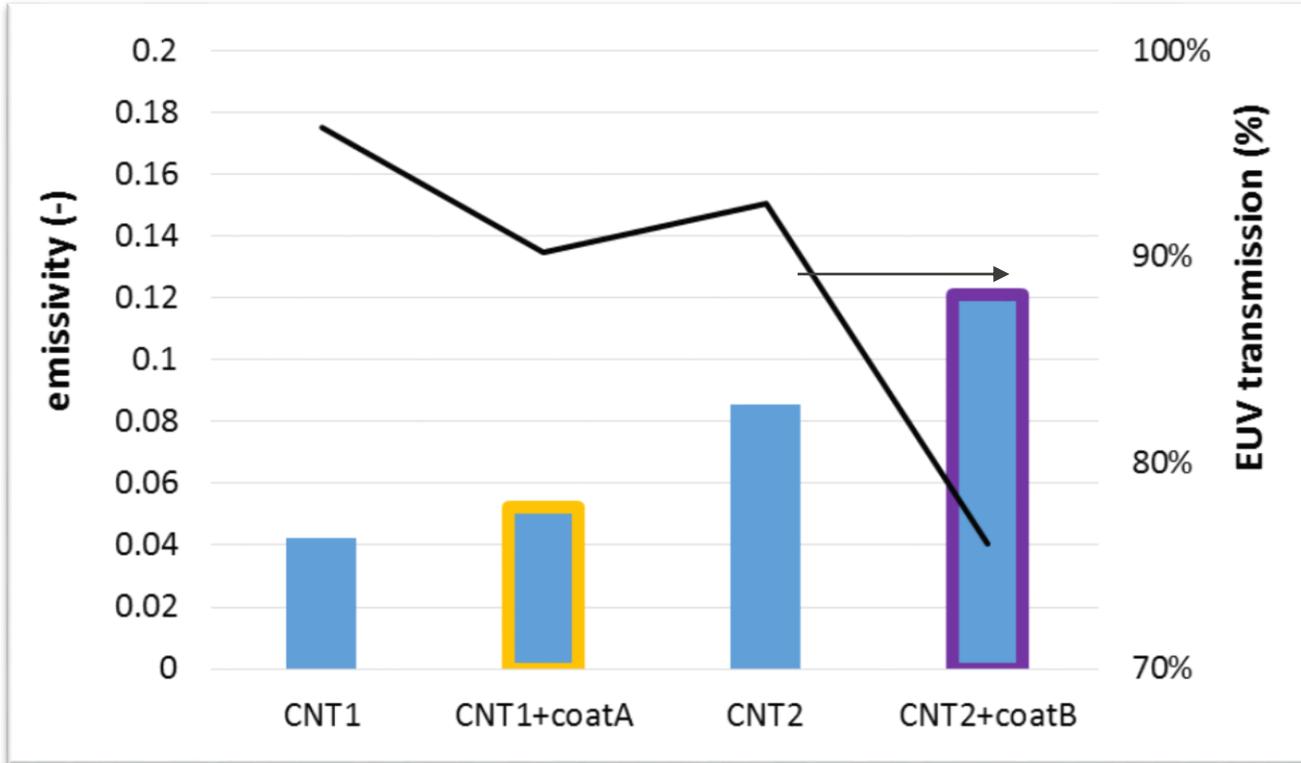
EMISSION MEASUREMENTS

TWO CNT-COATING SAMPLES



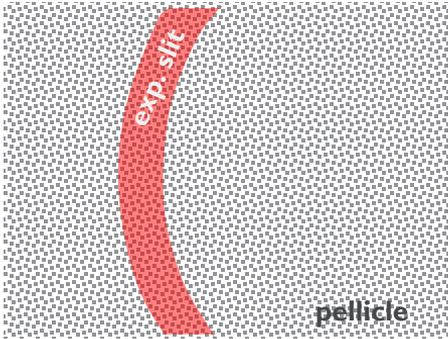
EMISSIONS OF CNT-BASED PELLICLES

TRANSMISSION INCLUDED



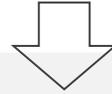
Improving emissivity cannot be at the penalty of too much transmission loss

OPTICAL AND THERMAL CONNECTION

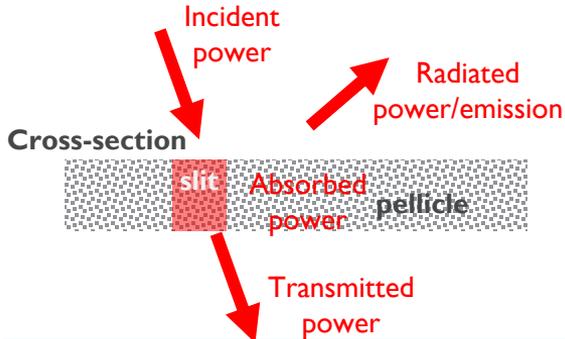


Power P is primarily transmitted or absorbed. In steady state, \sim all absorbed power is radiated (emissivity)

transmission = 1 - absorption



$$e^{-\alpha d} = \text{transmission} = 1 - \varepsilon \sigma S \frac{T_{max}^4 - T_0^4}{P}$$



d = pellicle thickness
 α = absorption
 ε = emissivity
 S = slit area = 10^{-3} m^2

P = power at reticle level = $0.2 \cdot P_{\text{source}}$ (W)
 σ = Stephan-Boltzman constant = $5.67 \times 10^{-8} \text{ W m}^{-2} \text{ K}^{-4}$
 T_0 = room temperature ($\sim 300\text{K}$)
 T_{max} = steady state pellicle temperature (K)

At 250W, there is a relationship between transmission, maximum temperature & emissivity

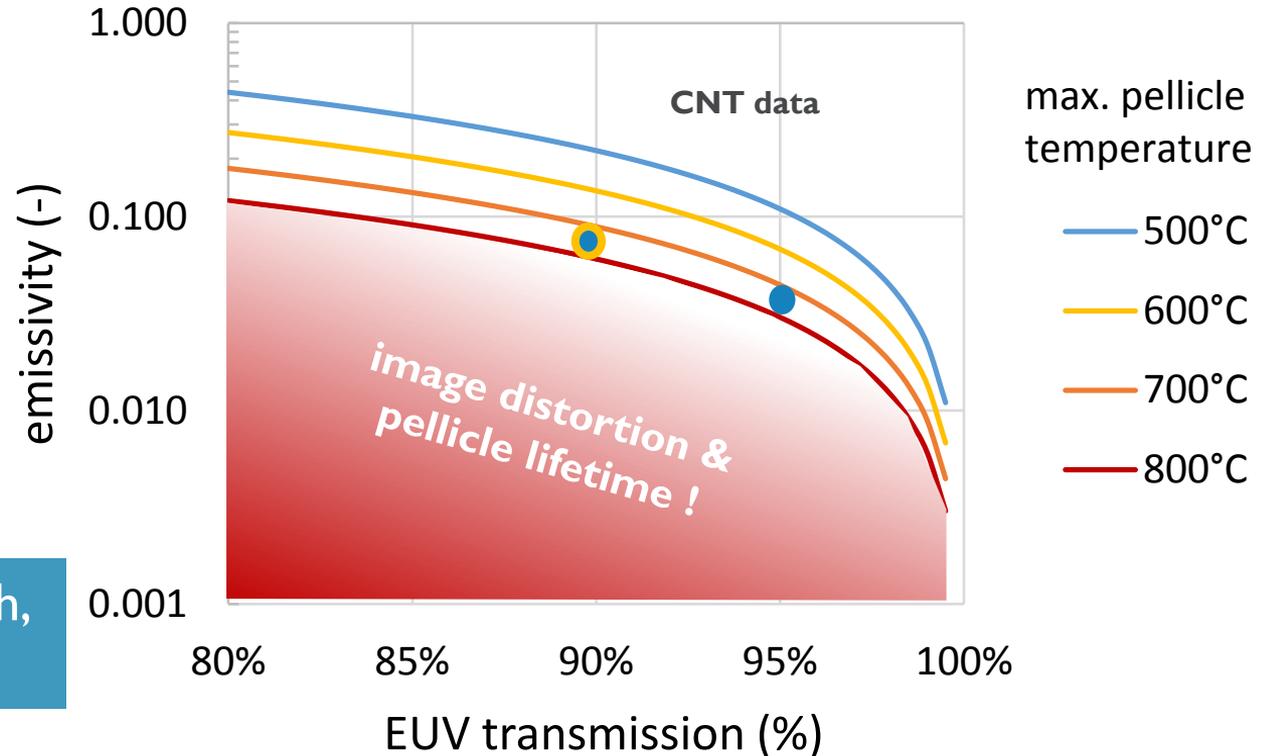
THERMAL & TRANSMISSION

EMISSION AND HEAT

- 250W source power
- Emissivity as a function of transmission for different maximum temperatures
- CNT examples added

If transmission is very high, emissivity can be lower

$$\text{transmission} = 1 - \varepsilon \sigma S \frac{T_{max}^4 - T_0^4}{P}$$



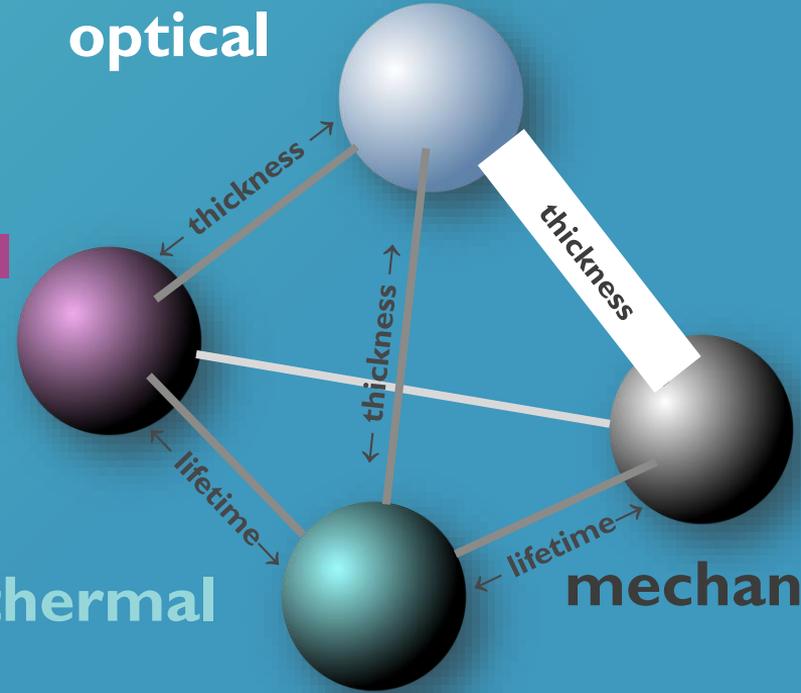
MECHANICAL TEST

chemical

optical

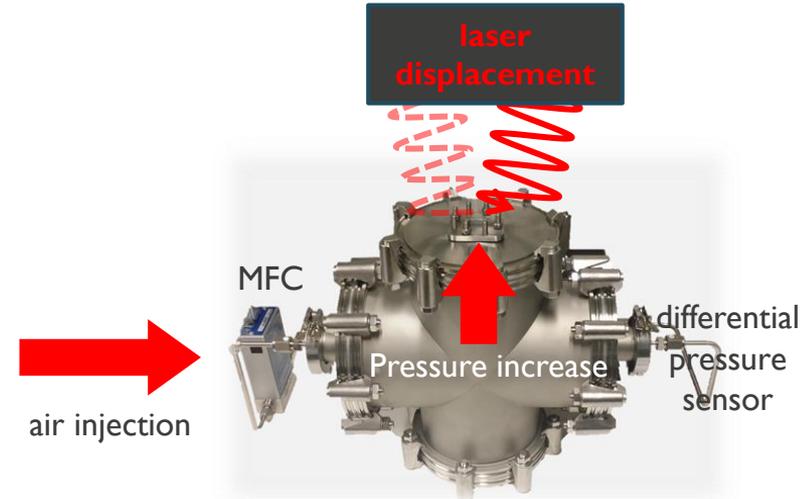
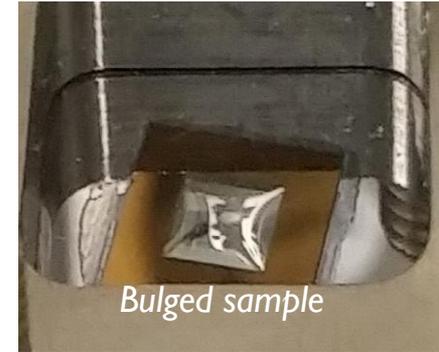
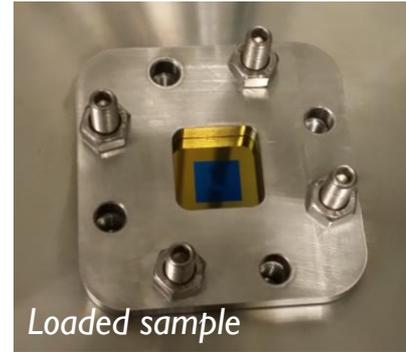
thermal

mechanical



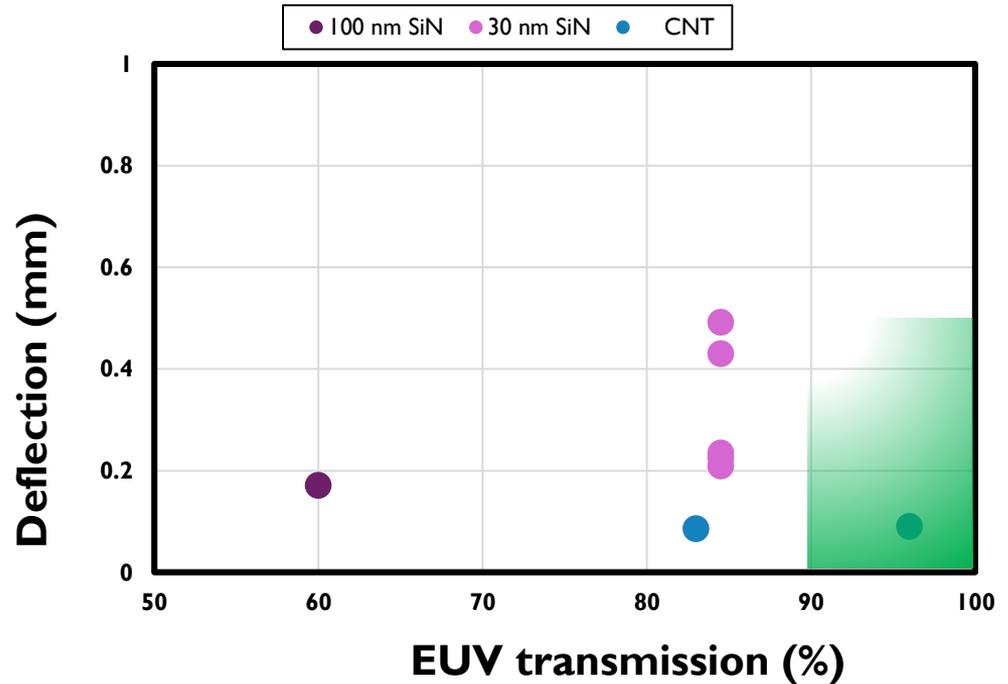
MECHANICAL: BULGE TESTER

1. Inject air to test membrane
2. Laser displacement measures deflection as a function of pressure
3. Record: displacement, pressure and pressure at failure (burst pressure)
4. Extract Young's modulus and intrinsic stress



DEFLECTION OF PELLICLE : SiN VS. CNT

- Bulge test with 2.2 Pa/s flow
- Deflection value obtained
 - SiN : deflection at burst pressure
 - CNT : maximum deflection
- Compare deflection & transmission on the same chart



CNTs maximum deflection was less than 0.1 mm

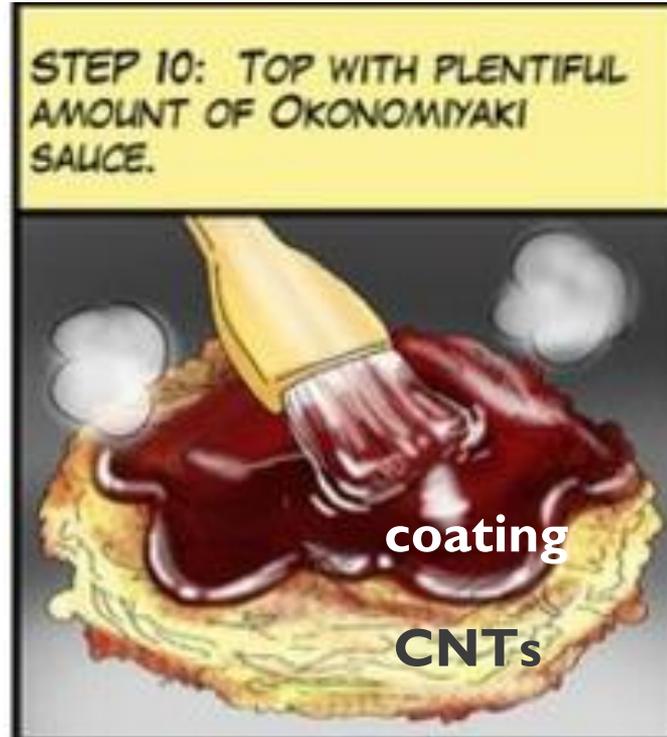
target region

SUMMARY

CLOSING THOUGHT

FOOD AND PELLICLES

- Fitting that CNT pellicles are discussed in Hiroshima, the city famous for its *Okonomiyaki*...



ACKNOWLEDGEMENTS

Thank you!

- Olivier Richard (imec) for TEM
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- Henning Richter (Nano-C) for CNT samples
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